

# **TMD2725** ALS, and Small Aperture Proximity Sensor Module

# **General Description**

The device features advanced proximity measurement and digital ambient light sensing (ALS). The package has been designed to accommodate a single small aperture approach. The slim module incorporates an IR LED and factory calibrated LED driver. The proximity detection feature provides object detection (e.g. mobile device screen to user's ear) by photodiode detection of reflected IR energy (sourced by the integrated LED). Detect/release events are interrupt driven, and occur when proximity result crosses upper and/or lower threshold settings. The proximity engine features offset adjustment registers to compensate for unwanted IR energy reflection at the sensor. Proximity results are further improved by automatic ambient light subtraction. The ALS detection feature provides photopic light intensity data. The ALS photodiode has UV and IR blocking filters and a dedicated data converter producing 16-bit data. This architecture allows applications to accurately measure ambient light which enables devices to calculate illuminance to control display backlight.

Ordering Information and Content Guide appear at end of datasheet.

# **Key Benefits & Features**

The benefits and features of TMD2725, ALS, and Small Aperture Proximity Sensor Module are listed below:

Figure 1: Added Value of Using TMD2725

Benefits	Features
Small aperture requirements	1.055mm emitter to detector distance
Single device integrated optical solution	<ul> <li>ALS + proximity</li> <li>2mm x 3.65mm x 1mm</li> <li>Integrated IR LED</li> <li>Power management features</li> <li>I<sup>2</sup>C fast mode interface compatible</li> </ul>
Accurate ambient light sensing	<ul> <li>Photopic Ambient Light Sensor (ALS)</li> <li>UV / IR blocking filters</li> <li>Programmable gain and integration time</li> </ul>
Reduced power consumption	• 1.8V power supply with 1.8V I <sup>2</sup> C bus



# **Applications**

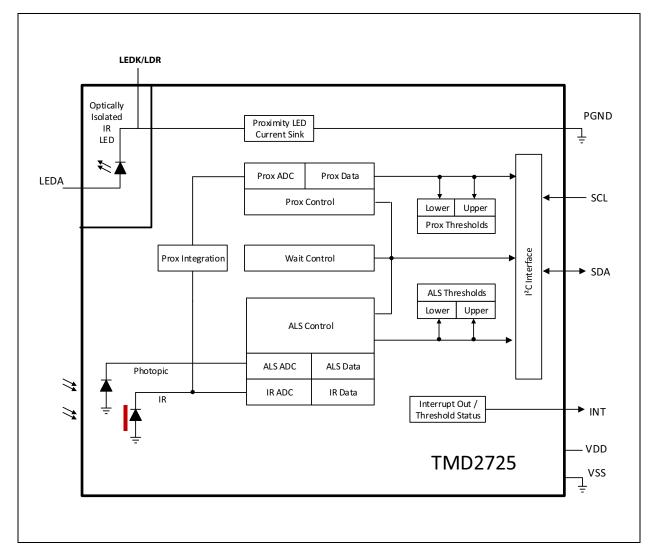
The TMD2725 applications include:

- Ambient light sensing
- Single hole proximity sensing
- Mobile phone touch screen disable

# **Block Diagram**

The functional blocks of this device are shown below:

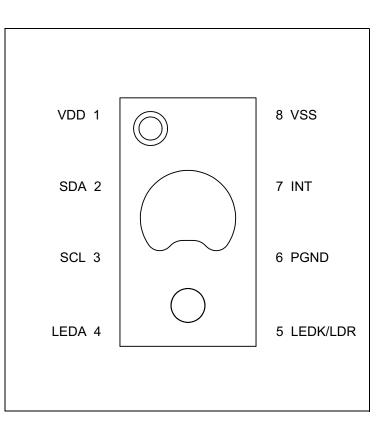
Figure 2: Functional Blocks of TMD2725





# **Pin Assignments**

Figure 3: Pin Diagram of TMD2725



#### Figure 4: Pin Description of TMD2725 (8-Pin Module)

Pin Number	Pin Name	Description
1	VDD	Supply voltage
2	SDA	I <sup>2</sup> C serial data I/O terminal
3	SCL	I <sup>2</sup> C serial clock input terminal
4	LEDA	LED anode
5	LEDK/LDR	This test point is the junction of the LED cathode and internal current source. Do not connect.
6	PGND	Ground for LED current sink and digital core
7	INT	Interrupt. Open drain output (active low)
8	VSS	Ground. All voltages are referenced to GND

# Absolute Maximum Ratings

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only. Functional operation of the device at these or any other conditions beyond those indicated under Electrical Characteristics is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

#### Figure 5: Absolute Maximum Ratings

Symbol	Parameter	Min	Max	Units	Comments					
		Electrica	l Paramet	ers						
VDD	Supply Voltage to Ground	-0.3	2.2	V						
LEDA	LED Voltage to PGND	-0.3	3.6	V						
V <sub>IO</sub>	Digital I/O terminal voltage	-0.3	3.6	V						
I <sub>IO</sub>	SDA, INT Output terminal current	-1	20	mA						
	Electrostatic Discharge									
Input Current I <sub>SCR</sub> (latch up immunity) ± 100 mA Class II JEDEC JESD78D										
ESD <sub>HBM</sub>	Electrostatic Discharge HBM JS-001-2014	± 2	000	V						
ESD <sub>CDM</sub>	Electrostatic Discharge CDM JEDEC JESD22-C101F	± 5	500	V						
	Temperatu	re Ranges	s and Stor	age Condi	tions					
T <sub>STRG</sub>	Storage Temperature Range	-40	85	°C						
T <sub>BODY</sub>	Package Body Temperature		260	°C	IPC/JEDEC J-STD-020 The reflow peak soldering temperature (body temperature) is specified according to IPC/JEDEC J-STD-020 "Moisture/Reflow Sensitivity Classification for Non-hermetic Solid State Surface Mount Devices."					
RH <sub>NC</sub>	Relative Humidity (non-condensing)	5	85	%						
MSL	Moisture Sensitivity Level		3		Maximum floor life time 168 hours					



# **Electrical Characteristics**

All limits are guaranteed. The parameters with min and max values are guaranteed with production tests or SQC (Statistical Quality Control) methods.

Figure 6:

**Recommended Operating Conditions** 

Parameter	Min	Тур	Мах	Unit
V <sub>DD</sub> supply range	1.7	1.8	2.0	V
V <sub>LEDA</sub> , Supply voltage range <sup>(1)</sup>	3.0	3.3	3.6	V
T <sub>A</sub> , Operating free-air temperature <sup>(2)</sup>	-30		85	°C

#### Note(s):

1. The minimum required supply voltage on the LED anode (VLEDA) is the sum of the LED's VF and the voltage drop from the LDR pin to PGND pin. The minimum required VLEDA can be lowered to 2.8V if the LED's forward current doesn't exceed 102mA (PLDRIVE value of 16 or less).

2. While the device is operational across the temperature range, performance will vary with temperature. Operational characteristics are at 25°C, unless otherwise noted.

Figure 7:

Operating Characteristics, VDD = 1.8V,  $T_A = 25^{\circ}C$  (unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
f <sub>OSC</sub>	Oscillator frequency			8.107		MHz
		Active ALS State (PON=AEN=1, PEN=0) <sup>(2)</sup>		80	80 150	
IDD	Supply Current <sup>(1)</sup>	ldle State (PON=1,AEN=PEN=0) <sup>(3)</sup>		30	60	μΑ
		Sleep State <sup>(4)</sup>	nte <sup>(4)</sup> 0.7	5		
VOL	INT, SDA output low voltage	6mA sink current			0.6	V
ILEAK	Leakage current, SDA,SCL,INT		-5		5	μA
VIH	SCL, SDA input high voltage		1.26		3.3	V
VIL	SCL, SDA input low voltage		0		0.54	V
T <sub>Active</sub>	Time from power-on to ready to receive I <sup>2</sup> C commands			1.5		ms

#### Note(s):

1. Values are shown at the VDD pin and do not include current through the IR LED.

- 2. This parameter indicates the supply current during periods of ALS integration. If Wait is enabled (WEN=1), the supply current is lower during the Wait period.
- 3. Idle state occurs when PON=1 and all functions are not enabled.
- 4. Sleep state occurs when PON = 0 and  $I^2C$  bus is idle. If Sleep state has been entered as the result of operational flow, SAI = 1, PON will remain high.

# **Typical Operating** Characteristics

Figure 8: Optical Characteristics, VDD = 1.8V, T<sub>A</sub> = 25°C (unless otherwise noted)

Parameter	Conditions	Cle	Unit			
rarameter	Conditions	Min	Тур	Мах	Chint	
	$\lambda_D = 465 \text{ nm LED}, 53.8 \ \mu\text{W/cm}^2$		58			
Re	$\lambda_D = 530 \text{ nm LED}, 43.9 \mu\text{W/cm}^2$		490		Count/	
Irradiance responsivity	$\lambda_D = 620 \text{ nm LED}, 37.5 \ \mu\text{W/cm}^2$		405		(µW/cm <sup>2</sup> )	
Settings: AGAIN = 16x	Warm White LED, 45.6 $\mu$ W/cm <sup>2</sup>		363			
ATIME = 400ms	Warm White LED, 45.6 $\mu$ W/cm <sup>2</sup>	14025	16500	18975	Counts	
	$\lambda_D = 950 \text{ nm LED, } 21.1 \ \mu\text{W/cm}^2$		8		Count/ (µW/cm <sup>2</sup> )	

#### Figure 9:

ALS Optical Characteristics, VDD = 1.8V,  $T_A = 25^{\circ}C$  (unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Unit
Integration time step size		2.72	2.82	2.94	ms
Dark ADC count value	$Ee = 0 \mu W/ cm2$ AGAIN: 64x ATIME = 100ms (0x23)	0	1	3	Counts
	AGAIN = 1x		1		
	AGAIN = 4x		4		
Gain Scaling, relative to 1x gain setting	AGAIN = 16x		16		x
	AGAIN = 64x		66		
	AGAIN = 128x		140		
ADC noise	AGAIN = 16x		0.005		% full scale



#### Figure 10: Proximity Optical Characteristics, VDD = 1.8V, T<sub>A</sub> = 25°C (unless otherwise noted)

Parameter	Conditions	Min	Тур	Max	Unit
Part to part variation <sup>(1)</sup>	Conditions: PGAIN = 2 (4x) PLDRIVE = 8 (54mA) PPULSE = 15 (16 pulses) PPULSE_LEN = 1 (8 $\mu$ s) d=23mm round target 30mm target distance	75	100	125	%
Response, absolute	Basic proximity measurement <sup>(2)</sup> Conditions: PGAIN = 2 (4x), PLDRIVE = 16 (102mA) PPULSE = 15 (16 pulses) PPULSE_LEN = 2 (16µs) Target material: 90% reflective surface of Kodak gray card Target Size: 100mm x 100mm Target Distance: 100mm	128	160	192	Counts
Response, no target	$PGAIN = 2 (4x)$ $ILEDDRIVE = 16 (102mA)$ $PPULSE = 16 (17 Pulses)$ $Pulse Length = 2 (16\mu S)$	0		20	
Noise/Signal <sup>(3)</sup>	PGAIN = 2 (4x) IRLEDDRIVE = 8 (54mA) PPULSE = 15 (16 pulses) PPULSE_LEN = 1 (8 $\mu$ s) d=23mm round target 30mm target distance			1.2	%

#### Note(s):

1. Production tested result is the average of 5 readings expressed relative to a calibrated response.

2. Representative result by characterization.

3. Production tested result is the average of 20 readings divided by the maximum proximity value 255.



#### Figure 11: Spectral Responsivity

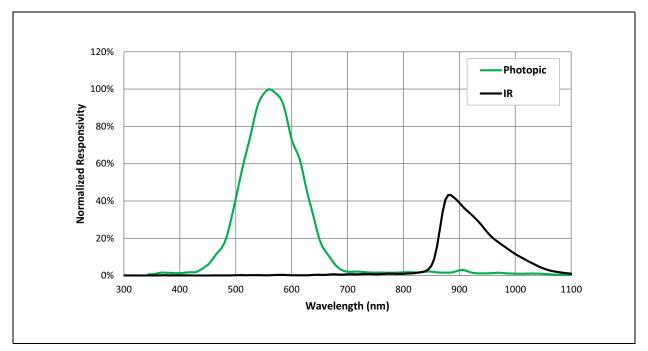
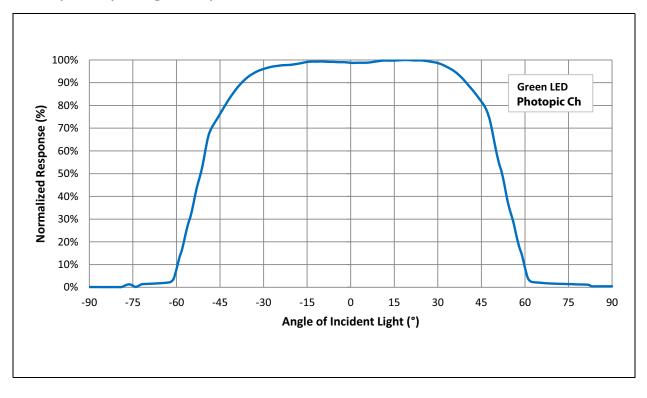
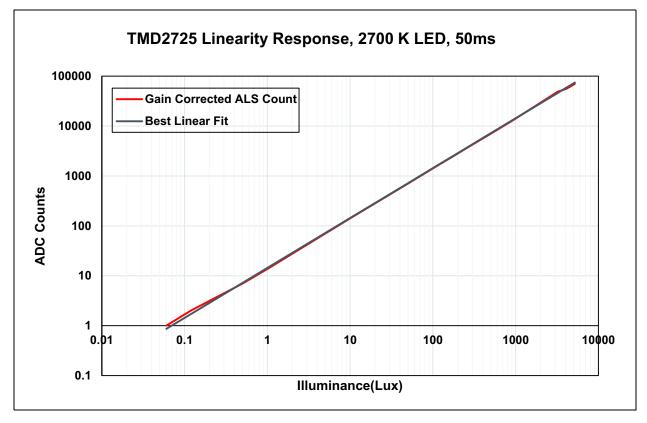


Figure 12: ALS Responsivity vs Angular Displacement

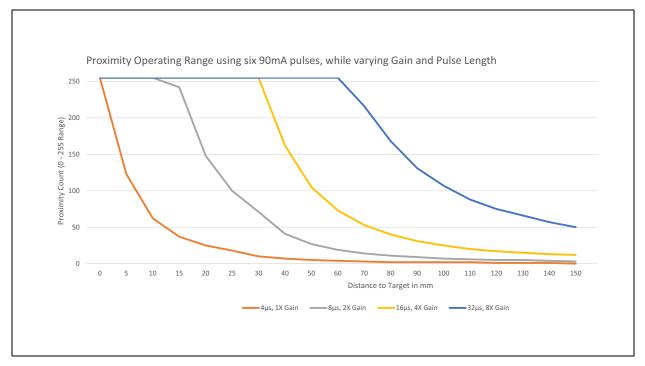








#### Figure 14: Proximity Operation of TMD2725



**Proximity Operation:** By varying Gain, LED drive current, number of LED pulses and LED pulse duration the proximity detection range can be adjusted.



# **Detailed Description**

### Proximity

Proximity results are affected by three fundamental factors: the integrated IR LED emission, IR reception, and environmental factors, including target distance and surface reflectivity.

The IR reception signal path begins with IR detection from a photodiode and ends with the 8-bit proximity result in PDATA register. Signal from the photodiode is amplified, and offset adjusted to optimize performance. Offset correction or cross-talk compensation is accomplished by adjustment to the POFFSET register.

The analog circuitry of the device applies the offset value as a subtraction to the signal accumulation; therefore a positive offset value has the effect of decreasing the results.

# Ambient Light Sensing, ALS

The ALS reception signal path begins as photodiodes receive filtered light and ends with the 16-bit results in the PHOTOPICL/H and ALS\_IRL/H registers. The Photopic photodiode is filtered with a UV and IR filter. The ALS\_IR photodiode is filtered to receive only IR. Signal from the photodiodes simultaneously accumulate for a period of time set by the value in ATIME before the results are available. Gain is adjustable from 1x to 64x to facilitate operation over a wide range of lighting conditions. Custom LUX equations are used to

calculate the amount of ambient light, as well as, determine the light type (e.g. LED, fluorescent, incandescent, etc.) using the two ALS results.

## I<sup>2</sup>C Characteristics

The device uses I<sup>2</sup>C serial communication protocol for communication. The device supports 7-bit chip addressing and both standard and fast clock frequency modes with a chip address of 0x39. Read and Write transactions comply with the standard set by Philips (now NXP).

Internal to the device, an 8-bit buffer stores the register address location of the desired byte to read or write. This buffer auto-increments upon each byte transfer and is retained between transaction events (I.e. valid even after the master issues a STOP command and the I<sup>2</sup>C bus is released). During consecutive Read transactions, the future/repeated I<sup>2</sup>C Read transaction may omit the memory address byte normally following the chip address byte; the buffer retains the last register address + 1.



#### **I<sup>2</sup>C Write Transaction**

A Write transaction consists of a START, CHIP-ADDRESS WRITE, REGISTER-ADDRESS, DATA BYTE(S), and STOP. Following each byte (9TH clock pulse) the slave places an ACKNOWLEDGE/ NOT-ACKNOWLEDGE (ACK/NACK) on the bus. If NACK is transmitted by the slave, the master may issue a STOP.

#### **I<sup>2</sup>C Read Transaction**

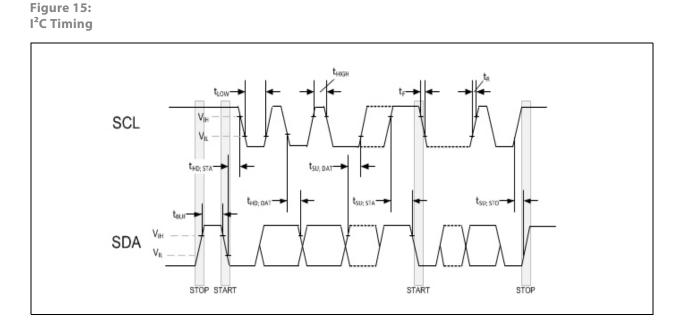
A Read transaction consists of a START, CHIP-ADDRESS WRITE, REGISTER-ADDRESS, START, CHIP-ADDRESS READ, DATA BYTE(S), and STOP. Following all but the final byte the master places an ACK on the bus (9TH clock pulse). Termination of the Read transaction is indicated by a NACK being placed on the bus by the master, followed by STOP.

Alternately, if the previous I<sup>2</sup>C transaction was a Read, the internal register address buffer is still valid, allowing the transaction to proceed without "re"-specifying the register address. In this case the transaction consists of a START, CHIP-ADDRESS<sub>READ</sub>, DATA BYTE(S), and STOP. Following all but

the final byte the master places an ACK on the bus (9<sup>TH</sup> clock pulse). Termination of the Read transaction is indicated by a NACK being placed on the bus by the master, followed by STOP.

The  $I^2C$  bus protocol was developed by Philips (now NXP). For a complete description of the  $I^2C$  protocol, please review the NXP  $I^2C$  design specification at:

http://www.i2c-bus.org/references/



#### **Timing Diagrams**

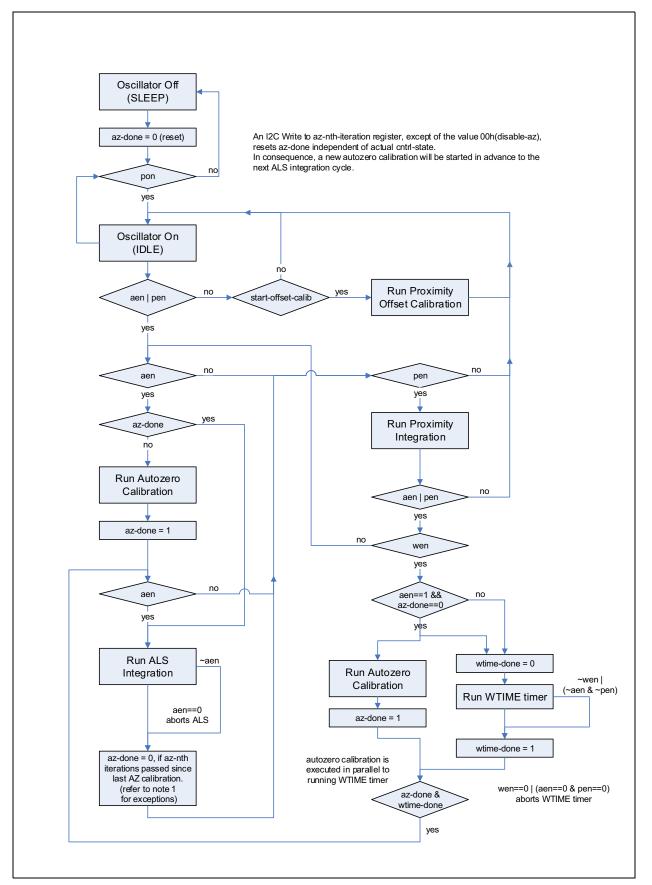


# **Principles of Operation**

## System State Machine

An internal state machine provides system control of the ALS, proximity detection, and power management features of the device. At power up, an internal power-on-reset initializes the device and puts it in a lowpower Sleep state. When a write on I<sup>2</sup>C bus to the Enable register (0x80) PON bit is set, the device transitions to the Idle state. If PON is disabled, the device will return to the Sleep state to save power. Otherwise, the device will remain in the Idle state until a Proximity or ALS function is enabled. Once enabled, the device will execute the ALS, Proximity and Wait states in sequence as indicated in Figure 16 and Figure 17. Upon completion, the device will automatically begin a new ALS-Prox-Wait cycle as long as PON and either PEN or AEN remain enabled. If the Prox or ALS function generates an interrupt and the Sleep-After-Interrupt (SAI) feature is enabled, the device will transition to the Sleep state and remain in a low-power mode until an I<sup>2</sup>C command is received clearing the interrupts in the STATUS register. See Interrupts for additional information.

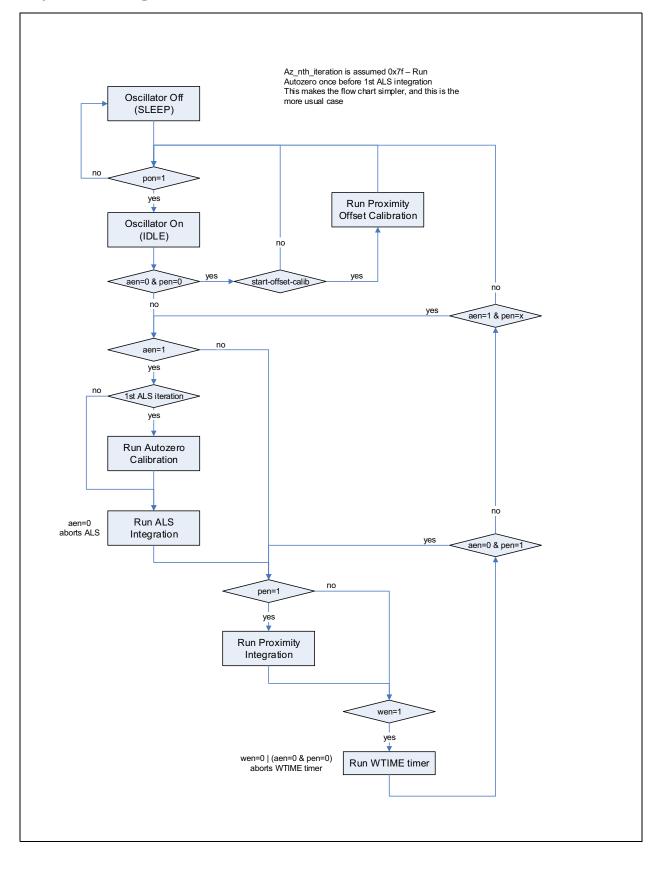
#### Figure 16: Detailed State Diagram



m



#### Figure 17: Simplified State Diagram



# **Register Description**

# **Register Overview**

Figure 18: Register Overview

Address	Register Name	R/W	Register Function	Reset Value
0x80	ENABLE	R/W	Enables states and functions	0x00
0x81	ATIME	R/W	ALS integration time	0x00
0x82	PRATE	R/W	Proximity sampling time	0x1F
0x83	WTIME	R/W	Wait time	0x00
0x84	AILTL	R/W	ALS interrupt low threshold low byte	0x00
0x85	AILTH	R/W	ALS interrupt low threshold high byte	0x00
0x86	AIHTL	R/W	ALS interrupt high threshold low byte	0x00
0x87	AIHTH	R/W	ALS interrupt high threshold high byte	0x00
0x88	PILT	R/W	Proximity interrupt low threshold	0x00
0x8A	PIHT	R/W	Proximity interrupt high threshold	0x00
0x8C	PERS	R/W	Interrupt persistence filters	0x00
0x8D	CFG0	R/W	Configuration register zero	0x80
0x8E	PCFG0	R/W	Proximity configuration register zero	0x4F
0x8F	PCFG1	R/W	Proximity configuration register one	0x80
0x90	CFG1	R/W	Configuration register one	0x00
0x91	REVID	R	Revision ID	0x20
0x92	ID	R	Device ID	0xE4
0x93	STATUS	R	Device status register	0x00
0x94	PHOTOPICL	R	Photopic channel data low byte	0x00
0x95	рноторісн	R	Photopic channel data high byte	0x00
0x96	ALS_IRL	R	IR channel data low byte	0x00
0x97	ALS_IRH	R	IR channel data high byte	0x00
0x9C	PDATA	R	Proximity channel data	0x00
0x9E	REVID2	R	Auxiliary ID	0x00
0x9F	CFG2	R/W	Configuration register two	0x04
0xAB	CFG3	R/W	Configuration register three	0x4C

# amu

Address	Register Name	R/W	Register Function	Reset Value
0xC0	POFFSETL	R/W	Proximity offset magnitude	0x00
0xC1	POFFSETH	R/W	Proximity offset sign	0x00
0xD6	AZ_CONFIG	R/W	Autozero configuration	0x7F
0xD7	CALIB	R/W	Calibration start	0x00
0xD9	CALIBCFG	R/W	Calibration configuration	0x50
0xDC	CALIBSTAT	R/W	Calibration status	0x00
0xDD	INTENAB	R/W	Interrupt enables	0x00

#### Note(s):

1. Address 0x98 and 0x99 will contain the results for the IR photodiode when controlled by the Green/IR MUX.

Register Access:

R = Read Only

W = Write Only

R/W = Read or Write

SC = Self Clearing after access

# **Detailed Register Description**

# Enable Register (Address 0x80)

Ac	ldr: 0x80			Enable		
Bit	Bit Name	Default	Access	Bit Description		
7:4	RESERVED	0000	RW	Reserved.		
3	WEN	0	RW	This bit activates the wait feature. Active high.		
2	PEN	0	RW	This bit activates the proximity detection. Active high.		
1	AEN	0	RW	This bit actives the ALS function. Active high. *Set AEN=1 and PON=1 in the same command to ensure auto-zero function is run prior to the first measurement.		
0	PON	0	RW	This field activates the internal oscillator and ADC channels. Active high.		

Before activating AEN or PEN, preset each applicable operating mode registers and bits.

Figure 19: Enable Register



# ATIME Register (Address 0x81)

Figure 20: ATIME Register

Ac	ldr: 0x81	ΑΤΙΜΕ								
Bit	Bit Name	Default	Access		Bit De	scription				
				ALS value that specifies the integration time in 2.78ms intervals. 0x00 indicates 2.8ms. The maximum ALS value depends on the integration time. For every 2.78ms, the maximum value increases by 1024. This means that to be able to reach ALS full scale, the integration time has to be at least 64*2.8ms.						
						l	Value	Integration Cycles	Integration Time	Maximum ALS Value
7:0	ATIME	0x00	RW	0x00	1	2.8ms	1023			
				0x01	2	5.6ms	2047			
									0x3F	64
				0xFF	256	719ms	65535			

The ATIME register controls the integration time of the ALS ADCs. The timer is implemented with a down counter with 0x00 as the terminal count. The timer is clocked at a 2.8ms nominal rate. Loading 0x00 will generate a 2.8ms integration time, loading 0x01 will generate a 5.6ms integration time, and so forth. The RC oscillator runs at 8MHz nominal rate. This gets divided by 11 to generate the integration clock of 727kHz. One count in ATIME (nominal 2.8ms) are 2.78ms. This is 2048 integration clock cycles: 125ns\*11\*8\*256=2.8ms.

## PTIME Register (Address 0x82)

Figure	21:
<b>PTIME</b>	Register

Addr: 0x82				PTIME
Bit	Bit Name	Default	Access	Bit Description
7:0	PTIME	0x1F	RW	This register defines the duration of 1 Prox Sample, which is (PTIME + 1)*88µs.

## WTIME Register (Address 0x83)

Figure 22: WTIME Register

Add	lr: 0x83	WTIME							
Bit	Bit Name	Default	Access		Bit Description				
				Value that specifie 2.78ms increment	es the wait time betw s.	veen ALS cycles in			
				Value	Increments	Wait Time			
			RW		0x00	1	2.8ms (33.8ms)		
7:0	WTIME	0x00		0x01	2	5.6ms (67.6ms)			
				0x3F	64	180ms (2.16s)			
				0xFF	256	719ms (8.65s)			

The wait timer is implemented using a down counter. Wait time = (value +1) x 2.8ms. If WLONG is enabled then Wait time = (value +1) x 2.8ms. x 12.

#### AILTL Register (Address 0x84)

Figure 23: AILTL Register

Addr: 0x84				AILTL
Bit	Bit Name	Default	Access	Bit Description
7:0	AILTL	0x00	RW	This register sets the low byte of the LOW ALS threshold.

The photopic channel is compared against low-going 16-bit threshold value set by AILTL and AILTH.



# AILTH Register (Address 0x85)

#### Figure 24: AILTH Register

Addr: 0x85		AILTH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	AILTH	0x00	RW	This register sets the high byte of the LOW ALS threshold.	

The photopic channel is compared against low-going 16-bit threshold value set by AILTL and AILTH.

The contents of the AILTH and AILTL registers are combined and treated as a sixteen bit threshold value. If the value generated by the photopic channel is below the AILTL/H threshold and the APERS value is reached, the AINT bit is asserted. If AIEN is set, then the INT pin will also assert.

When setting the 16-bit ALS threshold AILTL must be written first, immediately follow by AILTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 16-bit value.

# AIHTL Register (Address 0x86)

Figure 25: AIHTL Register

Addr: 0x86				AIHTL
Bit	Bit Name	Default	Access	Bit Description
7:0	AIHTL	0x00	RW	This register sets the low byte of the HIGH ALS threshold.

The photopic channel is compared against high-going 16-bit threshold value set by AIHTL and AIHTH.

The contents of the AIHTH and AIHTL registers are combined and treated as a sixteen bit threshold value. If the value generated by the photopic channel is above the AIHTL/H threshold and the APERS value is reached, the AINT bit is asserted. If AIEN is set, then the INT pin will also assert. When setting the 16-bit ALS threshold AIHTL must be written first, immediately follow by AIHTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 16-bit value.

### AIHTH Register (Address 0x87)

#### Figure 26: AIHTH Register

Addr: 0x87		AIHTH			
Bit	Bit Name	Default	Access	Bit Description	
7:0	AIHTH	0x00	RW	This register sets the high byte of the HIGH ALS threshold.	

The photopic channel is compared against high-going 16-bit threshold value set by AIHTL and AIHTH.

The contents of the AIHTH and AIHTL registers are combined and treated as a sixteen bit threshold value. If the value generated by the photopic channel is above the AIHTL/H threshold and the APERS value is reached, the AINT bit is asserted. If AIEN is set, then the INT pin will also assert. When setting the 16-bit ALS threshold AIHTL must be written first, immediately follow by AIHTH. Internally, the lower 8-bits are buffered until the upper 8-bits are written. As the upper 8-bits are written both the high and low bytes are simultaneously latched as a 16-bit value.

#### PILT Register (Address 0x88)

Figu	re 27:
PILT	Register

Addr: 0x88		PILT		
Bit	Bit Name	Default	Access	Bit Description
7:0	PILT	0x00	RW	This register sets the Proximity ADC channel low threshold.

The proximity channel is compared against low-going 8-bit threshold value set by PILT.

If the value generated by the Proximity channel is below the PILT threshold and the PPERS value is reached, the PINT bit is asserted. If PIEN is set, then the INT pin will also assert.



# PIHT Register (Address 0x8A)

#### Figure 28: PIHT Register

Addr: 0x8A			РІНТ	
Bit	Bit Name	Default	Access	Bit Description
7:0	PIHT	0x00	RW	This register sets the Proximity ADC channel high threshold.

The proximity channel is compared against high-going 8-bit threshold value set by PIHT.

If the value generated by the Proximity channel is above the PIHT threshold and the PPERS value is reached, the PINT bit is asserted. If PIEN is set, then the INT pin will also assert.

## PERS Register (Address 0x8C)

Figure 29: PERS Register

Addr: 0x8C			PERS					
Bit	Bit Name	Default	Access	Bit Description				
				This registe	r sets the Proximity persistence filter.			
				Value	Interrupt			
	7:4 PPERS 0000	-	0	Every Proximity Cycle				
7.4		0000	0000	DM	D)4/	0000 DW/	1	Any value outside PILT/PIHT thresholds
7:4		RW		2	2 consecutive proximity values out of range			
				3	3 consecutive proximity values out of range			
				15	15 consecutive proximity values out of range			

# amu

Add	Addr: 0x8C				PERS
Bit	Bit Name	Default	Access		Bit Description
			This register	r sets the ALS persistence filter.	
				0	Every ALS Cycle
				1	Any value outside ALS thresholds
				2	2 consecutive ALS values out of range
				3	3 consecutive ALS values out of range
		-	4	5 consecutive ALS values out of range	
3:0	3:0 APERS 0000	RW	5	10 consecutive ALS values out of range	
		6	15 consecutive ALS values out of range		
			7	20 consecutive ALS values out of range	
				13	50 consecutive ALS values out of range
				14	55 consecutive ALS values out of range
				15	60 consecutive ALS values out of range

The frequency of consecutive proximity channel results outside of threshold limits are counted; this count value is compared against the PPERS value. If the counter is equal to the PPERS value an interrupt is asserted. Any time a proximity channel result is inside the threshold values the counter is cleared. The frequency of consecutive photopic channel results outside of threshold limits are counted; this count value is compared against the APERS value. If the counter is equal to the APERS setting an interrupt is asserted. Any time a photopic channel result is inside the threshold values the counter is cleared.



# CFG0 Register (Address 0x8D)

#### Figure 30: CFG0 Register

Addr: 0x8D		CFG0			
Bit	Bit Name	Default	Access	Bit Description	
7:3	Reserved	10000	RW	This field must be set to the default value.	
2	WLONG	0	RW	When Wait Long is asserted the wait period as set by WTIME is increased by a factor of 12.	
1:0	Reserved	00	RW	This field must be set to the default value.	

The wait timer is implemented using a down counter. Wait time = (value +1) x 2.8ms. If WLONG is enabled then Wait time = (value +1) x 2.8ms x 12.

#### PCFG0 Register (Address 0x8E)

Figure 31: PCFG0 Register

Ad	Addr: 0x8E		PCFG0				
Bit	Bit Name	Default	Access		Bit Description		
				Proximity Pulse Ler	ngth		
				Value	Pulse Length		
7:6	PPULSE_LEN	01	RW	0	4µs		
7.0	FFOLSL_LLIN	01		1	8µs		
				2	16µs		
				3	32µs		
		001111	RW	Maximum Number	r of Pulses in a single proximity cycle.		
	5:0 PPULSE			Value	Maximum Number of Pulses		
				0	1		
5:0				1	2		
				2	3		
				63	64		

The PPULSE\_LEN field sets the width of all IR LED pulses within the proximity cycle. Longer pulses result in increased proximity range and typically result in less electrical noise generated in the analog front end. However, a setting of 8µs is recommended because less cumulative noise is generated during a proximity cycle.

The PPULSE field sets the maximum number of IR LED pulses that may occur in a proximity cycle. The proximity engine will automatically continue to add IR LED pulses, up to the value set in PPULSE or if a near-saturation condition occurs.

The dynamic range of the sensor is automatically adjusted to detect distant targets as well as prevent saturation from close targets.

This operation also reduces power consumption because proximity integration period is automatically shortened when a target is either to close or far from the sensor.

# PCFG1 Register (Address 0x8F)

Figure 32: PCFG1 Register

Addr: 0x8F		PCFG1					
Bit	Bit Name	Default	Access	1	Bit Description		
				This field sets the	gain of the proximi	ty IR sensor.	
				Gain	Value	Bit Field	
7:6	PGAIN	10	RW	1x	0	00b	
7.0	PGAIN	10	ΓVV	2x	1	01b	
				4x	2	10b	
				8x	3	11b	
5	Reserved	0	RW	Reserved	1		
				This field sets the o Values are approxi factory trimmed to	mate; actual curre	nt through LED is	
				Value	LED C	ürrent	
4:0			RW	0	бг	mA	
4.0	PLDRIVE	00000	ΓVV	1	12	mA	
				i <sub>lec</sub>	$_{\rm O} = 6(\rm PLDRIVE + 1) r$	mA	
				30	186	бmА	
				31	192	2mA	

# CFG1 Register (Address 0x90)

Figure 33: CFG1 Register

Addr: 0x90		CFG1				
Bit	Bit Name	Default	Default Access Bit Description		cription	
7:2	Reserved	000000	RW	RW Reserved		
				This field sets the gain of the	e ALS sensor.	
			Value	Gain		
1:0	AGAIN	00	DW	0	1x	
1.0	1:0 AGAIN 00	RW	1	4x		
				2	16x	
				3	64x	

# REVID Register (Address 0x91)

Figure 34: REVID Register

Addr: 0x91		REVID			
Bit	Bit Name	Default	Access	Bit Description	
7:3	Reserved	00100	RO	Reserved	
2:0	REV_ID	000	RO	Device revision number	

# ID Register (Address 0x92)

Figure 35: ID Register

Addr: 0x92		ID		
Bit	Bit Name	Default	Access	Bit Description
7:2	ID	111001	RO	Device type identification.
1:0	Reserved	00	RO	Reserved



## Status Register (Address 0x93)

Figure 36: Status Register

Addr: 0x93		Status Register			
Bit	Bit Name	Default	Access	Bit Description	
7	ASAT	0	R, SC	The Analog Saturation flag signals that the ALS results may be unreliable due to saturation of the AFE.	
6	PSAT	0	R, SC	The Proximity Saturation flag indicates that an ambient- or reflective-saturation event occurred during a previous proximity cycle.	
5	PINT	0	R, SC	The Proximity Interrupt flag indicates that proximity results have exceeded thresholds and persistence settings.	
4	AINT	0	R, SC	The ALS Interrupt flag indicates that ALS results (photopic channel) have exceeded thresholds and persistence settings.	
3	CINT	0	R, SC	The Calibration Interrupt flag indicates that calibration has completed.	
2	Reserved	0	R, SC	Reserved	
1	PSAT_REFLECTIVE	0	R, SC	The Reflective Proximity Saturation Interrupt flag signals that the AFE has saturated during the IR LED active portion of proximity integration.	
0	PSAT_AMBIENT	0	R, SC	The Ambient Proximity Saturation Interrupt flag signals that the AFE has saturated during the IR LED inactive portion of proximity integration.	

All flags in this register can be cleared by setting the bit high. Alternatively, if the CFG3.int\_read\_clear bit is set, then simply reading this register automatically clears all eight flags.

# PHOTOPICL Register (Address 0x94)

Figure 37: PHOTOPICL Register

Addr: 0x94		PHOTOPICL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	PHOTOPICL	0x00	RO	This register contains the low byte of the 16-bit photopic channel data.	

## **PHOTOPICH Register (Address 0x95)**

#### Figure 38: PHOTOPICH Register

Addr: 0x95		РНОТОРІСН			
Bit	Bit Name	Default	Access	Bit Description	
7:0	PHOTOPICH	0x00	RO	This register contains the high byte of the 16-bit photopic channel data.	

# ALS\_IRL Register (Address 0x96)

Figure 39: ALS\_IRL Register

Addr: 0x96		ALS_IRL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	ALS_IRL	0x00	RO	This register contains the low byte of the 16-bit IR channel data.	

## ALS\_IRH Register (Address 0x97)

Figure 40: ALS\_IRH Register

Addr: 0x97		ALS_IRH		
Bit	Bit Name	Default	Access	Bit Description
7:0	ALS_IRH	0x00	RO	This register contains the high byte of the 16-bit IR channel data.

# PDATA Register (Address 0x9C)

Figure 41: PDATA Register

Addr: 0x9C		PDATA		
Bit	Bit Name	Default	Access	Bit Description
7:0	PDATA	0x00	RO	This register contains the 8-bit proximity channel data.



# REVID2 Register (Address 0x9E)

Figure 42: REVID2 Register

Ad	Addr: 0x9E			REVID2
Bit	Bit Name	Default	Access	Description
7:4	Reserved	0000	RO	Reserved
3:0	REVID2	0000	RO	Package Identification

# CFG2 Register (Address 0x9F)

Figure 43: CFG2 Register

Addr: 0x9F			CFG2			
Bit	Bit Name	Default	Access	Bit Description		
7:5	Reserved	000	RW	Reserved		
4	AGAINMAX	0	RW	This bit adjusts the overall ALS gain factor. See Figure 44 for recommended settings and corresponding overall ALS gain factor.		
3	Reserved	0	RW	Reserved		
2	AGAINL	1	RW	This bit adjusts the overall ALS gain factor. See Figure 44 for recommended settings and corresponding overall ALS gain factor.		
1:0	Reserved	00	RW	Reserved		

The ALS gain can be adjusted using by setting the two AGAIN bits as well as the AGAINL bit which yields an overall range from  $\frac{1}{2}$  x to 128x.



#### Figure 44: AGAIN Range

AGAIN[1]	AGAIN[0]	AGAINMAX	AGAINL	Overall ALS Gain
0	0	0	0	1/2
0	0	0	1	1
0	1	0	1	4
1	0	0	1	16
1	1	0	1	64
1	1	1	1	128

# CFG3 Register (Address 0xAB)

Figure 45: CFG3 Register

A	Addr: 0xAB		CFG3					
Bit	Bit Name	Default Access Bit Description						
7	INT_READ_CLEAR	0 RW		If the Interrupt-Clear-by-Read bit is set, then all flag bits in the STATUS register will be reset whenever the STATUS register is read over I <sup>2</sup> C.			-	
6:5	Reserved	10	RW	Reserved				
				-	ter Interrupt k I low power m		place the interrupt pin	
				PON	SAI	INT	Oscillator	
4	SAI	0	RW	0	Х	Х	OFF	
				1	0	Х	ON	
		1	1	1	ON			
				1	1	0	OFF	
3:0	Reserved	1100	RW	Reserved				

The SAI bit sets the device operational mode following the completion of an ALS or proximity cycle. If AINT and AIEN are both set or if PINT and PIEN are both set, causing an interrupt on the INT pin, and the SAI bit is set, then the oscillator will deactivate. The Device will appear as if PON = 0, however, PON will read as 1. The device can only be reactivated (oscillator enabled) by clearing the interrupts in the STATUS register.

# POFFSETL Register (Address 0xC0)

Figure 46: POFFSETL Register

Addr: 0xC0		POFFSETL			
Bit	Bit Name	Default	Access	Bit Description	
7:0	POFFSETL	0x00	RW	This register contains the magnitude portion of proximity offset adjust value.	

Typically, optical and/or electrical crosstalk negatively influence proximity operation and results. The POFFSETL/POFFSETH registers provide a mechanism to remove system crosstalk from the proximity data. POFFSETL and POFFSETH contains the magnitude and sign of a value which adjusts PDATA generated in the AFE. An offset value in the range of ± 255 is possible.

## POFFSETH Register (Address 0xC1)

Figure 47: POFFSETH Register

Addr: 0xC1		POFFSETH			
Bit	Bit Name	Default	Access	Bit Description	
7:1	Reserved	0000000	RW	Reserved	
0	POFFSET_SIGN	0	RW	This register contains the sign portion of proximity offset adjust value.	



## AZ\_CONFIG Register (Address 0xD6)

#### Figure 48: AZ\_CONFIG Register

Addr: 0xD6		AZ_CONFIG			
Bit	Bit Name	Default	Access	Description	
7	Reserved	0	RW	Reserved.	
6:0	AZ_NTH_ ITERATION	1111111	RW	Run autozero automatically before every nth ALS cycle (00h = never, n = every nth ALS cycle, and 7Fh = only before the first ALS cycle).	

#### CALIB Register (Address 0xD7)

Figure 49: CALIB Register

Addr: 0xD7		CALIB				
Bit	Bit Name	Default	Access	Bit Description		
7:6	Reserved	00	RO	Reserved		
5	ELECTRICAL_ CALIBRATION	0	RW	Selects proximity calibration type. 1 = electrical offset only. 0 = calibration compensates for electrical and optical crosstalk.		
4:1	Reserved	0000	RW	Reserved		
0	START_OFFSET_ CALIB	0	RW	Set to 1 to start a calibration sequence.		

Proximity response in systems with electrical and optical crosstalk may be improved by using the calibration feature. Optical crosstalk is caused when the photodiode receives a small portion of the LED IR which was unintentionally reflected by a surface other than the target. Electrical offset is caused by electrical disturbance in the sensor AFE, and also influences the proximity result. The calibration routine adjusts the value in registers C0 and C1 until the proximity result is as close to BINSRCH\_TARGET as possible without becoming zero. Optical and electrical calibration function identically, except that during an electrical calibration the proximity photodiode is disconnected from the AFE.

An electrical only calibration can be initiated by setting the ELECTRICAL\_CALIBRATION and START\_OFFSET\_CALB bits. To perform an optical (and electrical) calibration do not set the ELECTRICAL\_CALIBRATION bit when setting the START\_ OFFSET\_CALIB. The CINT flag will assert after calibration has



finished.

Upon completion Proximity offset registers are automatically loaded with calibration result.

# CALIBCFG Register (Address 0xD9)

Figure 50: CALIBCFG Register

A	Addr: 0xD9		CALIBCFG				
Bit	Bit Name	Default	Access	Bit Description			
				Proximity Result Target			
				Value	PDATA Target		
				0	0		
				1	1		
7:5	BINSRCH_	010	RW	2	3		
7.5	TARGET	010	1100	3	7		
				4	15		
				5	31		
				6	63		
				7	127		
4	Reserved	1	RW	Reserved			
3	AUTO_ OFFSET_ADJ	0	RW	The Proximity Auto Offset Adjus POFFSETL register to decrement completion of the proximity cyc	when PDATA equals zero at the		
				The Proximity Averaging field de samples collected and averaged the proximity result.			
				Value	Sample Size		
				0	Disable		
				1	2		
2:0	PROX_AVG	000	RW	2	4		
				3	8		
				4	16		
				5	32		
				6	64		
				7	128		



The binary search target field is used by the calibration feature to set the baseline value for PDATA when no target is present. For example, calibration of a device in open air, with no target, and BINSEARCH\_TARGET setting of 4 causes the PDATA value will be approximately 15 counts. This feature is useful because it forces PDATA result to always be above zero. The PBOX\_AVG field sets the number of ADC samples that are

The PROX\_AVG field sets the number of ADC samples that are averaged to calculate the PDATA result.

## CALIBSTAT Register (Address 0xDC)

Figure 51: CALIBSTAT Register

Ac	Addr: 0xDC		CALIBSTAT			
Bit	Bit Name	Default	Access	Bit Description		
7:1	Reserved	0000000	RW	Reserved		
0	CALIB_FINISHED	0	RW	This flag indicates that calibration has finished. It can only be cleared by setting this bit high.		

#### INTENAB Register (Address 0xDD)

#### Figure 52: INTENAB Register

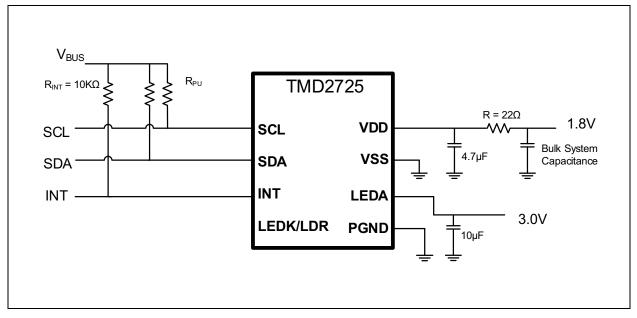
Add	Addr: 0xDD			INTENAB
Bit	Bit Name	Default	Access	Bit Description
7	ASIEN	0	RW	ALS Saturation Interrupt Enable
6	PSIEN	0	RW	Proximity Saturation Interrupt Enable
5	PIEN	0	RW	Proximity Interrupt Enable
4	AIEN	0	RW	ALS Interrupt Enable
3	CIEN	0	RW	Calibration Interrupt Enable
2:0	Reserved	000	RW	Reserved



# **Application Information**

# Schematic

Figure 53: Typical Applications Circuit

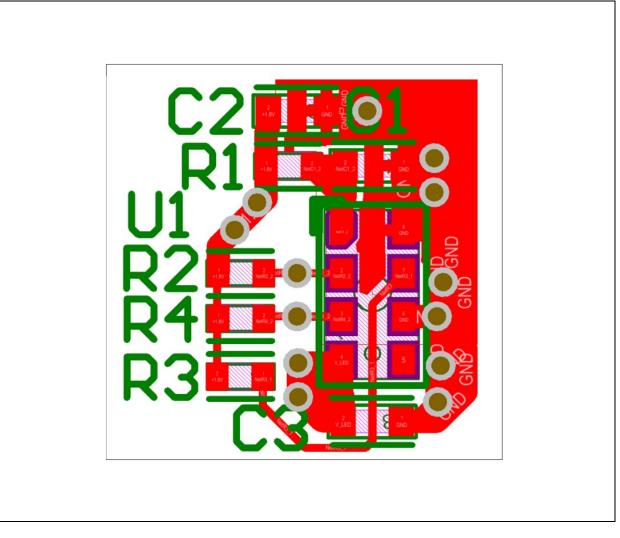


**Typical Applications Circuit:** It is important to place the  $4.7\mu$ F (VDD) and  $10\mu$ F (LEDA) capacitors at the package pins.



PCB Layout

Figure 54: Typical Applications Circuit

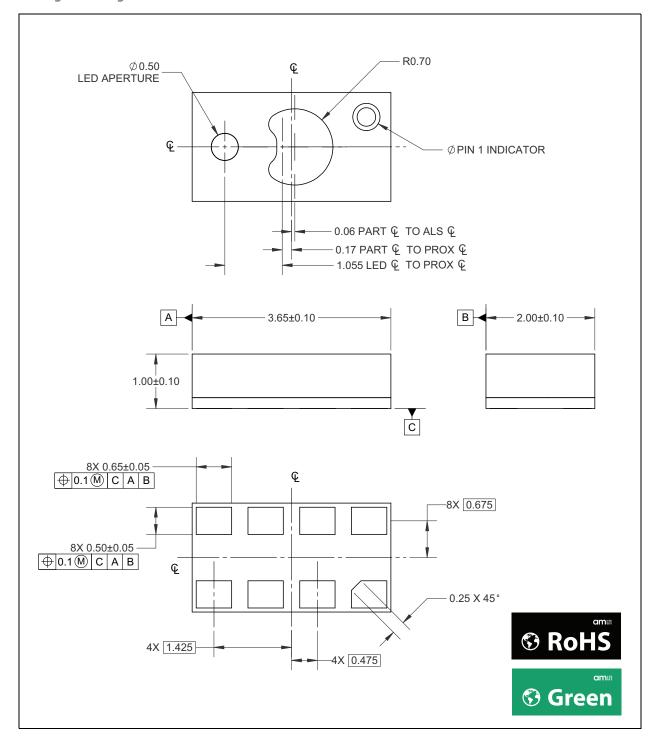


The dominant factor governing device performance is the component placement, not necessarily component value. The placement of the decoupling capacitor, C1, is the most critical. Place the component on the same side of PCB as device as shown in the figure above. Make connection as close as possible to minimize series inductance and resistance. This is critical.



## **Package Drawings & Markings**

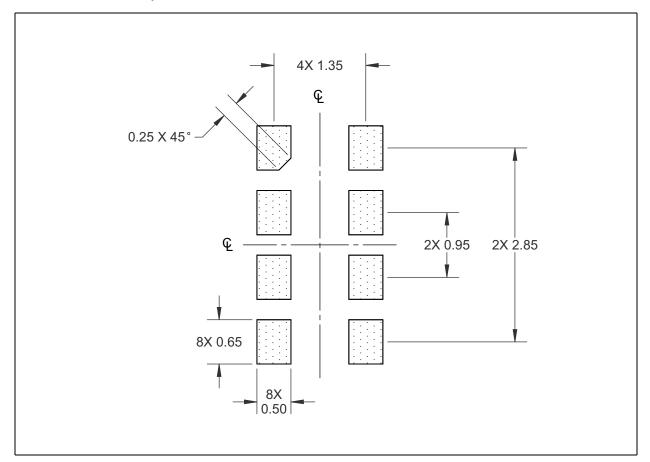
Figure 55: Package Drawings



#### Note(s):

- 1. All linear dimensions are in millimeters.
- 2. Contact finish is Au.
- 3. This package contains no lead (Pb).
- 4. This drawing is subject to change without notice.

#### Figure 56: Recommended PCB Layout



#### Note(s):

- 1. All dimensions are in millimeters.
- 2. Dimension tolerances are 0.05mm unless otherwise noted.
- 3. This drawing is subject to change without notice.

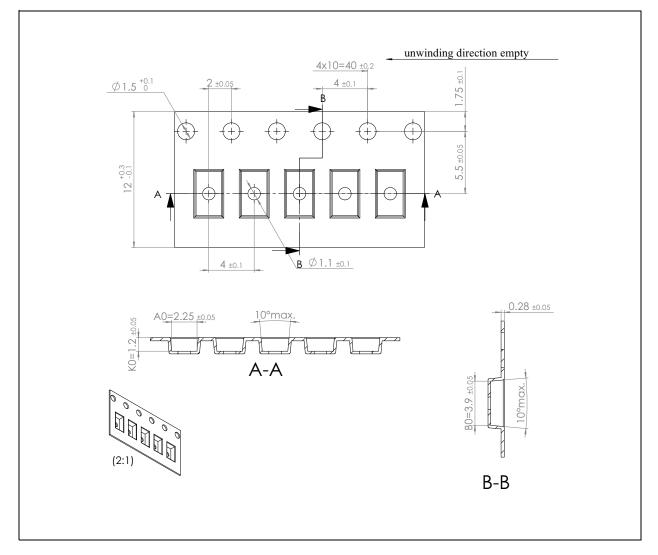
am



## **Tape & Reel Information**

#### Figure 57:

**Tape and Reel Information** 



#### Note(s):

1. All linear dimensions are in millimeters.

2. For missing tolerances and dimensions, refer to EIA-481.

3. In accordance with EIA standard, device pin 1 is located next to the sprocket holes in the tape.



## Soldering & Storage Information

The module has been tested and has demonstrated an ability to be reflow soldered to a PCB substrate. The solder reflow profile describes the expected maximum heat exposure of components during the solder reflow process of product on a PCB. Temperature is measured on top of component. The components should be limited to a maximum of three passes through this solder reflow profile.

Figure	58:	
Solder	Reflow	Profile

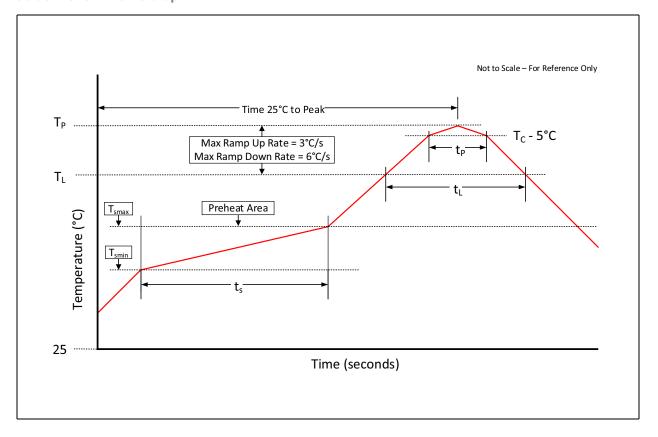
Profile Feature Preheat/ Soak	Sn-Pb Eutectic Assembly	Pb-Free Assembly	
Temperature Min (T <sub>smin</sub> )	100 ℃	150 °C	
Temperature Max (T <sub>smax</sub> )	150 ℃	200 °C	
Time (t <sub>s</sub> ) from (T <sub>smin</sub> to T <sub>smax</sub> )	60-120 seconds	60-120 seconds	
Ramp-up rate (T <sub>L</sub> to T <sub>P</sub> )	3 °C/second max.	3 °C/second max.	
Liquidous temperature $(T_L)$ Time $(t_L)$ maintained above $T_L$	183 °C 60-150 seconds	217 °C 60-150 seconds	
Peak package body temperature (T <sub>P</sub> )	For users T <sub>P</sub> must not exceed the Classification temp of 235 °C For suppliers T <sub>P</sub> must equal or exceed the Classification temp of 235 °C	For users T <sub>P</sub> must not exceed the Classification temp of 260 °C For suppliers T <sub>P</sub> must equal or exceed the Classification temp of 260 °C	
Time (t <sub>P</sub> ) <sup>(1)</sup> within 5 °C of the specified classification temperature (T <sub>c</sub> )	20 <sup>(1)</sup> seconds	30 <sup>(1)</sup> seconds	
Ramp-down rate $(T_P \text{ to } T_L)$	6 °C/second max.	6 °C/second max.	
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.	

#### Note(s):

1. Tolerance for peak profile temperature (TP) is defined as a supplier minimum and a user maximum.



#### Figure 59: Solder Reflow Profile Graph



#### **Storage Information**

Moisture Sensitivity Optical characteristics of the device can be adversely affected during the soldering process by the release and vaporization of moisture that has been previously absorbed into the package. To ensure the package contains the smallest amount of absorbed moisture possible, each device is baked prior to being dry packed for shipping. Devices are dry packed in a sealed aluminized envelope called a moisture-barrier bag with silica gel to protect them from ambient moisture during shipping, handling, and storage before use.

### Shelf Life

The calculated shelf life of the device in an unopened moisture barrier bag is 12 months from the date code on the bag when stored under the following conditions:

- Shelf Life: 12 months
- Ambient Temperature: <40°C
- Relative Humidity: <90%

Rebaking of the devices will be required if the devices exceed the 12 month shelf life and the Humidity Indicator Card shows that the devices were exposed to conditions beyond the allowable moisture region.



## **Floor Life**

The module has been assigned a moisture sensitivity level of MSL 3. As a result, the floor life of devices removed from the moisture barrier bag is 168 hours from the time the bag was opened, provided that the devices are stored under the following conditions:

- Floor Life: 168 hours
- Ambient Temperature: <30°C
- Relative Humidity: <60%

If the floor life or the temperature/humidity conditions have been exceeded, the devices must be rebaked prior to solder reflow or dry packing.

#### **Rebaking Instructions**

When the shelf life or floor life limits have been exceeded, rebake at  $50^{\circ}$ C for 12 hours.



## **Ordering & Contact Information**

Figure 60:

**Ordering Information** 

Ordering Code	I <sup>2</sup> C Bus	I <sup>2</sup> C Address	Delivery Form	Delivery Quantity
TMD27253M	1.8V	39h	Tape & Reel (7")	1000 pcs/reel
TMD27253	1.00	5511	Tape & Reel (13")	10000 pcs/reel

Buy our products or get free samples online at: www.ams.com/ICdirect

Technical Support is available at: www.ams.com/Technical-Support

Provide feedback about this document at: www.ams.com/Document-Feedback

For further information and requests, e-mail us at: ams\_sales@ams.com

For sales offices, distributors and representatives, please visit: www.ams.com/contact

#### Headquarters

ams AG Tobelbader Strasse 30 8141 Premstaetten Austria, Europe

Tel: +43 (0) 3136 500 0 Website: www.ams.com

## RoHS Compliant & ams Green Statement

**RoHS:** The term RoHS compliant means that ams AG products fully comply with current RoHS directives. Our semiconductor products do not contain any chemicals for all 6 substance categories, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, RoHS compliant products are suitable for use in specified lead-free processes.

**ams Green (RoHS compliant and no Sb/Br):** ams Green defines that in addition to RoHS compliance, our products are free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material).

**Important Information:** The information provided in this statement represents ams AG knowledge and belief as of the date that it is provided. ams AG bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. ams AG has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. ams AG and ams AG suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

# amu

## Copyrights & Disclaimer

Copyright ams AG, Tobelbader Strasse 30, 8141 Premstaetten, Austria-Europe. Trademarks Registered. All rights reserved. The material herein may not be reproduced, adapted, merged, translated, stored, or used without the prior written consent of the copyright owner.

Devices sold by ams AG are covered by the warranty and patent indemnification provisions appearing in its General Terms of Trade. ams AG makes no warranty, express, statutory, implied, or by description regarding the information set forth herein. ams AG reserves the right to change specifications and prices at any time and without notice. Therefore, prior to designing this product into a system, it is necessary to check with ams AG for current information. This product is intended for use in commercial applications. Applications requiring extended temperature range, unusual environmental requirements, or high reliability applications, such as military, medical life-support or life-sustaining equipment are specifically not recommended without additional processing by ams AG for each application. This product is provided by ams AG "AS IS" and any express or implied warranties, including, but not limited to the implied warranties of merchantability and fitness for a particular purpose are disclaimed.

ams AG shall not be liable to recipient or any third party for any damages, including but not limited to personal injury, property damage, loss of profits, loss of use, interruption of business or indirect, special, incidental or consequential damages, of any kind, in connection with or arising out of the furnishing, performance or use of the technical data herein. No obligation or liability to recipient or any third party shall arise or flow out of ams AG rendering of technical or other services.

## **Document Status**

Document Status	Product Status	Definition
Product Preview	Pre-Development	Information in this datasheet is based on product ideas in the planning phase of development. All specifications are design goals without any warranty and are subject to change without notice
Preliminary Datasheet	Pre-Production	Information in this datasheet is based on products in the design, validation or qualification phase of development. The performance and parameters shown in this document are preliminary without any warranty and are subject to change without notice
Datasheet	Production	Information in this datasheet is based on products in ramp-up to full production or full production which conform to specifications in accordance with the terms of ams AG standard warranty as given in the General Terms of Trade
Datasheet (discontinued)	Discontinued	Information in this datasheet is based on products which conform to specifications in accordance with the terms of ams AG standard warranty as given in the General Terms of Trade, but these products have been superseded and should not be used for new designs



## **Revision Information**

Changes from 1-12 (2017-Nov-01) to current revision 1-13 (2018-Feb-23)	Page
Updated ATIME Register (Address 0x81)	18
Updated WTIME Register (Address 0x83)	19
Updated CALIB Register (Address 0xD7)	33

#### Note(s):

1. Page and figure numbers for the previous version may differ from page and figure numbers in the current revision.

2. Correction of typographical errors is not explicitly mentioned.

### **Content Guide**

- 1 General Description
- 1 Key Benefits & Features
- 2 Applications
- 2 Block Diagram
- 3 Pin Assignments
- 4 Absolute Maximum Ratings
- 5 Electrical Characteristics
- 6 Typical Operating Characteristics

#### 10 Detailed Description

- 10 Proximity
- 10 Ambient Light Sensing, ALS
- 10 I<sup>2</sup>C Characteristics
- 11 I<sup>2</sup>C Write Transaction
- 11 I<sup>2</sup>C Read Transaction
- 11 Timing Diagrams

#### **12** Principles of Operation

- 12 System State Machine
- 15 Register Description
- 15 Register Overview
- 17 Detailed Register Description
- 17 Enable Register (Address 0x80)
- 18 ATIME Register (Address 0x81)
- 18 PTIME Register (Address 0x82)
- 19 WTIME Register (Address 0x83)
- 19 AILTL Register (Address 0x84)
- 20 AILTH Register (Address 0x85)
- 20 AIHTL Register (Address 0x86)
- 21 AIHTH Register (Address 0x87)
- 21 PILT Register (Address 0x88)
- 22 PIHT Register (Address 0x8A)
- 22 PERS Register (Address 0x8C)
- 24 CFG0 Register (Address 0x8D)
- 25 PCFG0 Register (Address 0x8E)
- 26 PCFG1 Register (Address 0x8F)
- 27 CFG1 Register (Address 0x90)
- 27 REVID Register (Address 0x91)
- 27 ID Register (Address 0x92)
- 28 Status Register (Address 0x93)
- 28 PHOTOPICL Register (Address 0x94)
- 29 PHOTOPICH Register (Address 0x95)
- 29 ALS\_IRL Register (Address 0x96)
- 29 ALS\_IRH Register (Address 0x97)
- 29 PDATA Register (Address 0x9C)
- 30 REVID2 Register (Address 0x9E)
- 30 CFG2 Register (Address 0x9F)
- 31 CFG3 Register (Address 0xAB)
- 33 POFFSETL Register (Address 0xC0)
- 33 POFFSETH Register (Address 0xC1)
- 33 AZ CONFIG Register (Address 0xD6)
- 34 CALIB Register (Address 0xD7)

## amui

- 35 CALIBCFG Register (Address 0xD9)
- 36 CALIBSTAT Register (Address 0xDC)
- 36 INTENAB Register (Address 0xDD)

#### 37 Application Information

- 37 Schematic
- 38 PCB Layout
- **39** Package Drawings & Markings
- 41 Tape & Reel Information

#### 42 Soldering & Storage Information

- 43 Storage Information
- 43 Shelf Life
- 44 Floor Life
- 44 Rebaking Instructions
- 45 Ordering & Contact Information
- 46 RoHS Compliant & ams Green Statement
- 47 Copyrights & Disclaimer
- 48 Document Status
- 49 Revision Information

## **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Ambient Light Sensors category:

Click to view products by ams manufacturer:

Other Similar products are found below :

IS31SE5000-UTLS2-TR SEN0390 0805-PTSM D021 ALS-PT19-315C/L177/TR8 BH1680FVC-TR SI1132-A10-GM APS3227SP1C-P22 ALS-PDIC144-6C/L378 4681 AS7211-BLGM AS7211-BLGT AS7220-BLGM AS7221-BLGM AS7341-DLGM AS7341-DLGT TMD27253M TMD27504 TMD37024VCM TMD37253M TSL25403M TSL27403M DY-FPD204-6B/L3 DY-FPD333-3B/L3 DY-FPD333B-A5 DY-FPD4134C-A3 DY-PD204-6B DY-PD234-6B DY-PD333B-A5 DY-PD673B-A2 CLS15-22C/L213G/TR8 CLS15-22C/L213R/TR8 HLPT51850HP25 LTR-303ALS-01 LTR-329ALS-01 LTR-308ALS-01 NJL7502L LV0111CF-TLM-H SFH 3711 BH1603FVC-TR BH1620FVC-TR BH1621FVC-TR BH1710FVC-TR BH1715FVC-TR BH1721FVC-TR BH1730FVC-TR BH1749NUC-E2 BH1750FVI-TR BH1751FVI-TR RPR-0521RS OPT3007YMFR